PAN00SV56V

N-Ch 100V Fast Switching MOSFET

V_{DS}=100V, I_D=27A, $RDS_{(ON)}$=20mΩ

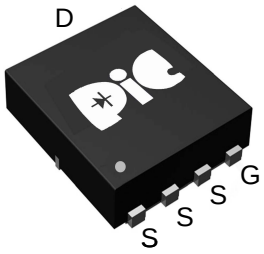
➢ General Description

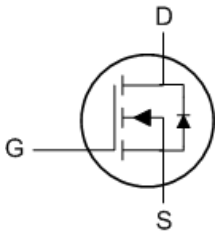
This PAN00SV56V N-Channl enhancement mode power field effect transistor is the high density trench technology and this advanced technology can provide excellent Rds(On) performance and efficiency for power switching and load switching application., this device also comply with the RoHS and Green Product requirement with full function reliability approved.

➢ Feature

- ●Super Low Gate Charge
- ●100% EAS Guaranteed
- ●Green Device Available
- ●Excellent CdV/dt effect decline
- ●Advanced high cell density Trench technology

➢ DFN3X3A-EP1





➢ Application

- ●DC/DC Primary Side Switch
- ●Industrial Synchronous
- ●Rectification Load Switch
- ●DC/DC Converters

➢ Absolute Maximum Ratings

Parameter	Symbol	Rating	Units
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	±20	V
Continuous Drain Current, V_{GS} @ 10V[1]	I_D@T_C=25℃	27	A
Continuous Drain Current, V_{GS} @ 10V[1]	I_D@T_C=100℃	17	A
Continuous Drain Current, V_{GS} @ 10V[1]	I_D@T_A=25℃	7.9	A
Continuous Drain Current, V_{GS} @ 10V[1]	I_D@T_A=70℃	6.3	A
Pulsed Drain Current[2]	I_{DM}	80	A
Single Pulse Avalanche Energy[3]	EAS	45	mJ
Avalanche Current	I_{AS}	30	A
Total Power Dissipation[4]	P_D@T_C=25℃	27.7	W
Total Power Dissipation[4]	P_D@T_A=25℃	2.3	W
Storage Temperature Range	T_{STG}	-55 to 150	℃
Operating Junction Temperature Range	T_J	-55 to 150	℃
Thermal Resistance Junction-Ambient [1]	$R_{\theta JA}$	55	℃/W
Thermal Resistance Junction-Case[1]	$R_{\theta JC}$	4.5	℃/W

➢ Electrical Characteristics (T_J=25°C Unless otherwise noted)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS}=0V , I_D=250uA	100	---	---	V
Static Drain-Source On-Resistance[2]	$R_{DS(ON)}$	V_{GS}=10V , I_D=10A	---	16	20	mΩ
		V_{GS}=4.5V , I_D=10A	---	21	30	
Gate Threshold Voltage	$V_{GS(th)}$	V_{GS}=V_{DS} , I_D =250uA	1.2	1.8	2.2	V
Drain-Source Leakage Current	I_{DSS}	V_{DS}=80V , V_{GS}=0V , T_J=25℃	---	---	1	uA
		V_{DS}=80V , V_{GS}=0V , T_J=55℃	---	---	5	
Gate-Source Leakage Current	I_{GSS}	V_{GS}=±20V , V_{DS}=0V	---	---	±100	nA
Gate Resistance	R_g	V_{DS}=0V , V_{GS}=0V , f=1MHz	---	1	---	Ω
Total Gate Charge	Q_g	V_{DS}=50V , V_{GS}=10V , I_D=10A	---	17.9	---	nC
Gate-Source Charge	Q_{gs}		---	2.8	---	
Gate-Drain Charge	Q_{gd}		---	5.2	---	
Turn-On Delay Time	$T_{d(on)}$	V_{DD}=30V , V_{GS}=10V , R_G=6Ω, I_D=1A	---	13	---	ns
Rise Time	T_r		---	6	---	
Turn-Off Delay Time	$T_{d(off)}$		---	30	---	
Fall Time	T_f		---	29	---	
Input Capacitance	C_{iss}	V_{DS}=50V , V_{GS}=0V , f=1MHz	---	849	---	pF
Output Capacitance	C_{oss}		---	185	---	
Reverse Transfer Capacitance	C_{rss}		---	8	---	

➢ Diode Characteristics

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Continuous Source Current[1,6]	I_S	V_G=V_D=0V , Force Current	---	---	27	A
Diode Forward Voltage[2]	V_{SD}	V_{GS}=0V , I_S=1A , T_J=25℃	---	---	1.2	V

Note :
1.Pulse width limited by maximum junction temperature.
2.The data tested by pulsed , pulse width ≦ 300us , duty cycle ≦ 2%
3.The EAS data shows Max. rating . The test condition is V_{DD}=25V,V_{GS}=10V,L=0.1mH,I_{AS}=30A
4.Ensure that the channel temperature does not exceed 150°C.
5.The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.

➢ Typical Characteristics

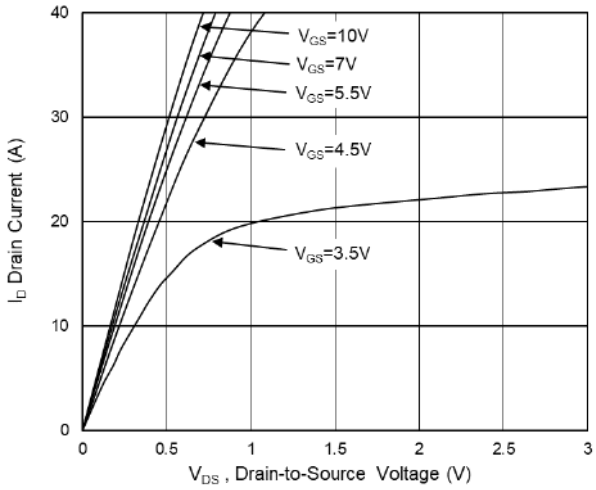


Fig.1 Typical Output Characteristics

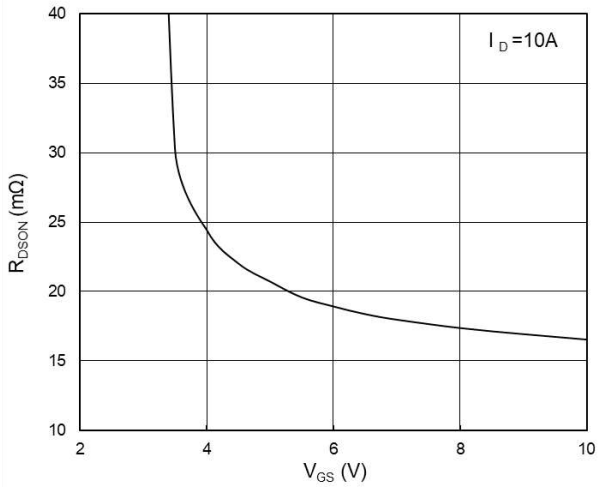


Fig.2 On-Resistance vs G-S Voltage

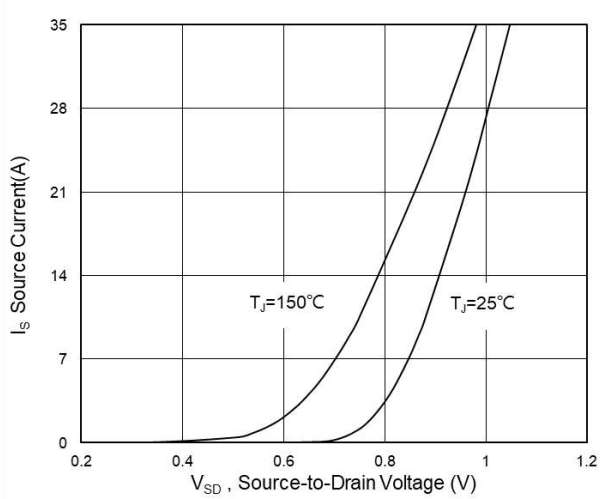


Fig.3 Source Drain Forward Characteristics

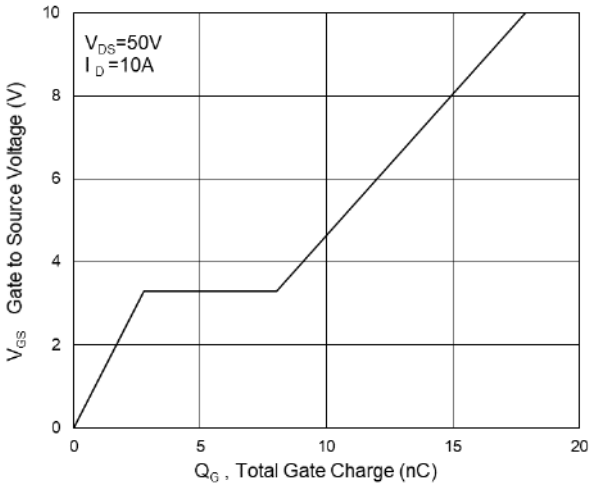


Fig.4 Gate-Charge Characteristics

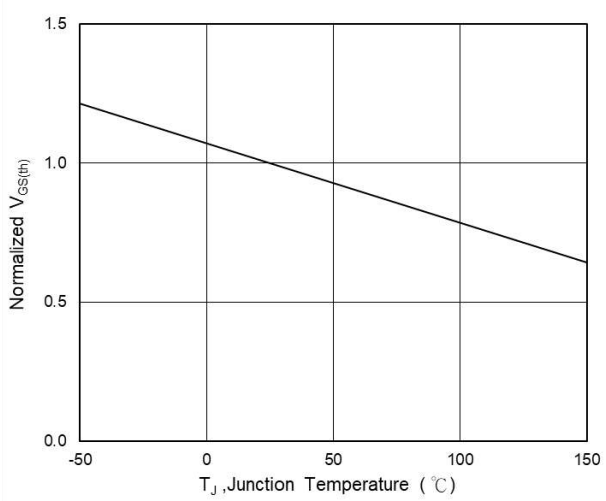


Fig.5 Normalized $V_{GS(th)}$ vs T_J

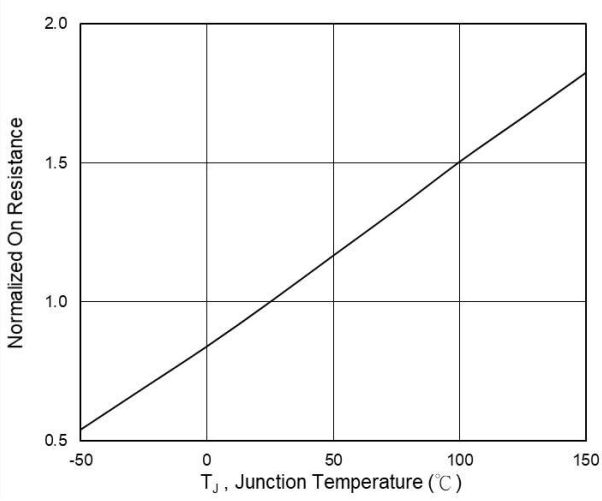


Fig.6 Normalized R_{DSON} vs T_J

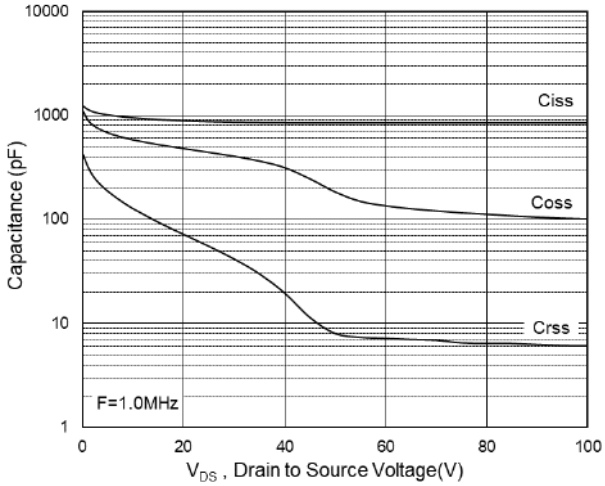


Fig.7 Capacitance

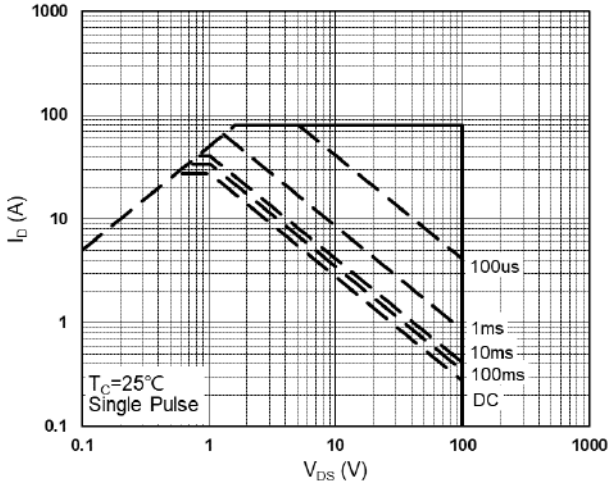


Fig.8 Safe Operating Area

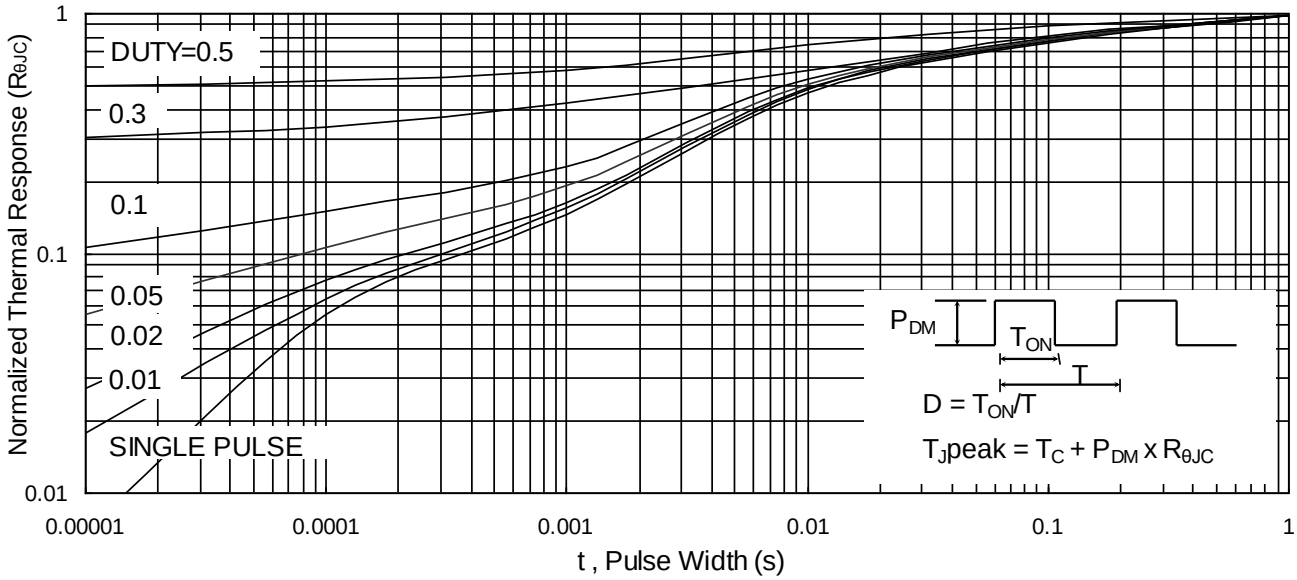


Fig.9 Normalized Maximum Transient Thermal Impedance

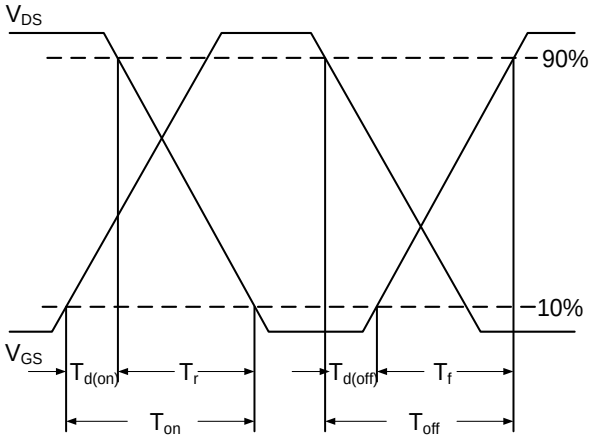


Fig.10 Switching Time Waveform

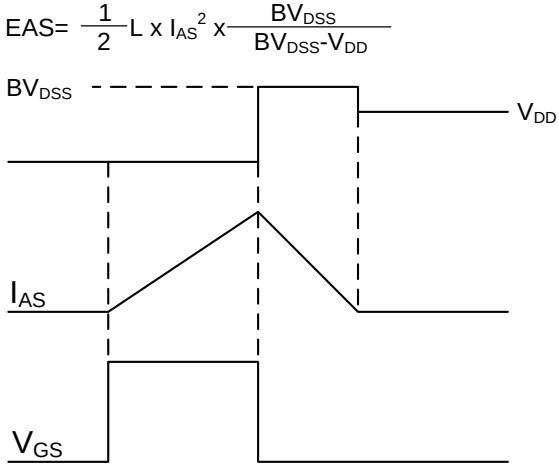
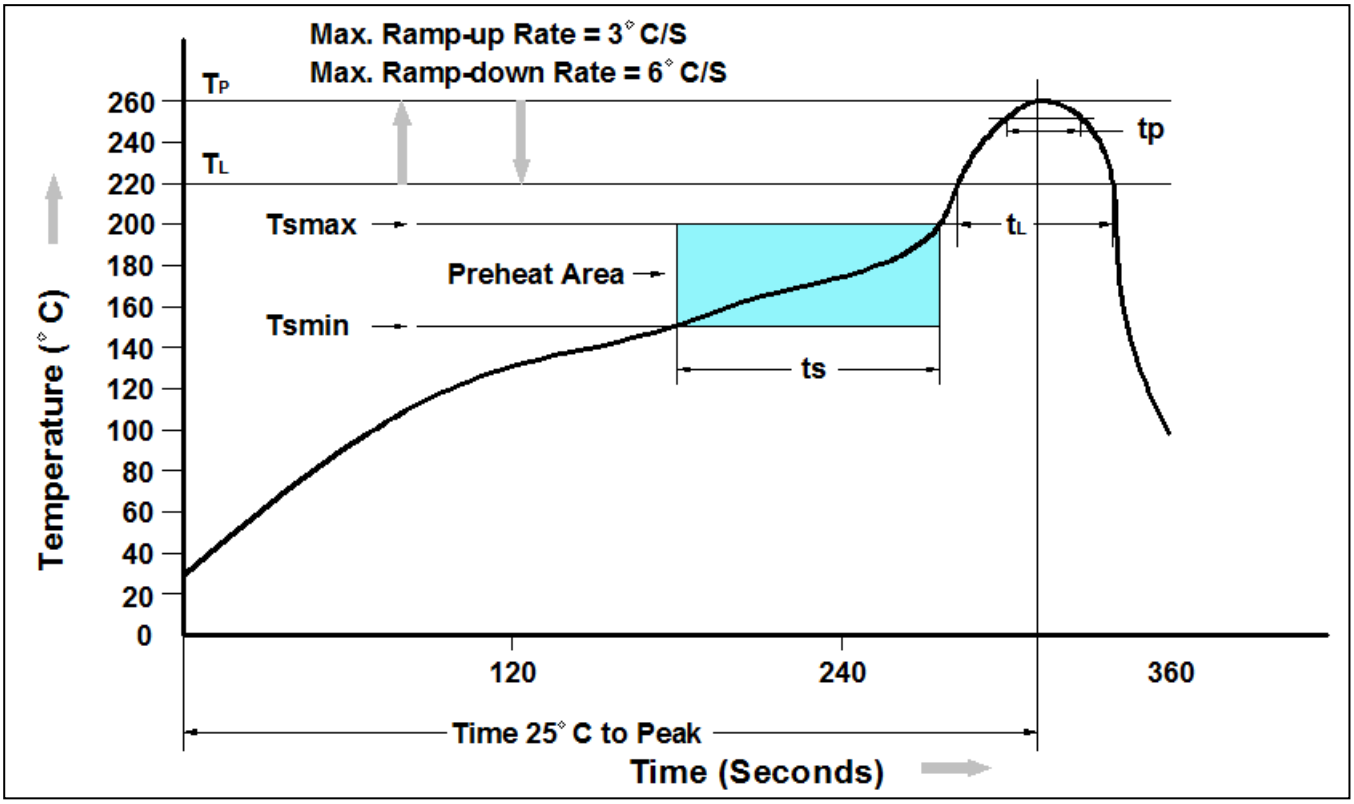


Fig.11 Unclamped Inductive Switching Waveform

➢ Recommand IR Reflow Soldering Thermal Profile

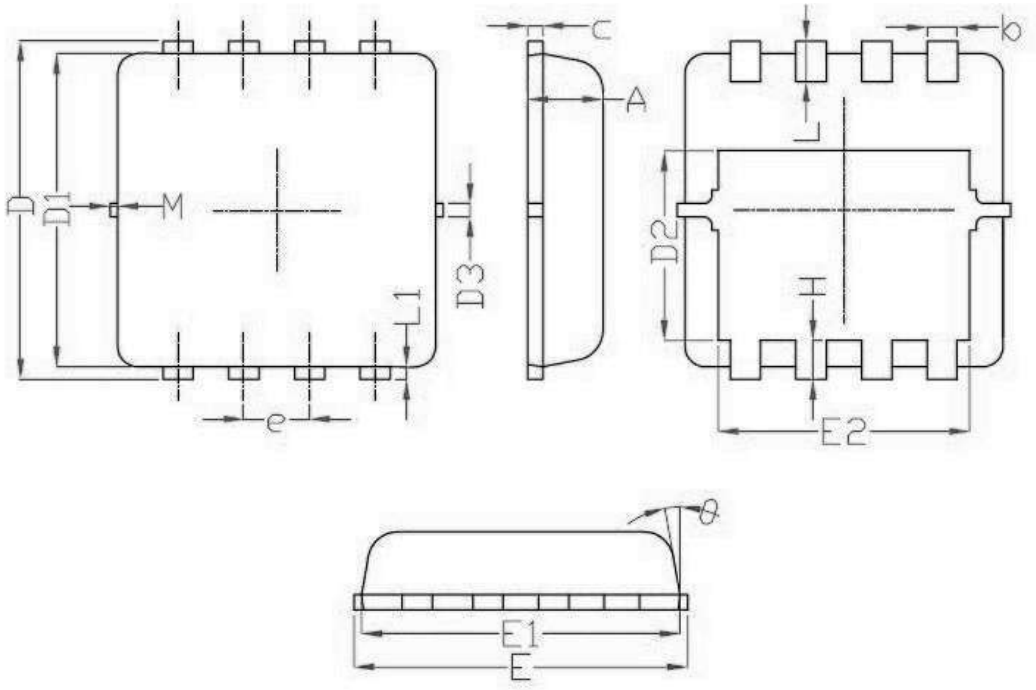


Profile Feature	Pb-Free Assembly Profile
Temperature Min. (Tsmin)	150°C
Temperature Max. (Tsmax)	200°C
Time (ts) from (Tsmin to Tsmax)	60-120 seconds
Average Ramp-up Rate (tL to tP)	3°C/second max.
Liquidous Temperature (TL)	217°C
Time (tL) Maintained Above (TL)	60 – 150 seconds
Peak Temperature	260°C +0°C / -5°C
Time (tP) within 5°C of actual Peak Temperature	30 seconds
Ramp-down Rate (TP to TL)	6°C/second max
Time 25°C to Peak Temperature	8 minutes max.

➢ Ordering Information

Part Number	Description	Quantity
PAN00SV56V	DFN3X3A-EP1 Reel	3000 pcs

➢ Package Information (DFN3X3A-EP1)



SYMBOLS	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	0.70	0.85	0.027	0.034
b	0.20	0.40	0.007	0.016
c	0.10	0.25	0.004	0.010
D	3.15	3.45	0.124	0.136
D1	2.90	3.20	0.114	0.126
D2	1.54	1.98	0.060	0.080
D3	0.10	0.30	0.004	0.012
E	3.15	3.45	0.124	0.136
E1	3.00	3.25	0.118	0.128
E2	2.29	2.65	0.090	0.104
e	0.65 BSC		0.025 BSC	
H	0.28	0.65	0.011	0.026
Θ	0°	14°	0°	14°
L	0.30	0.50	0.012	0.020
L1	0.13		0.005	
M	---	0.15	---	0.006

DISCLAIMER

- The information in this document and any product described herein are subject to change without notice and should not be construed as a commitment by Paceleader, Paceleader reserve the right to make changes to the information in this document.

- Though Paceleader make effort to improve product quality and reliability, Product can malfunction and fail due to their inherent electrical sensitivity and vulnerability to physical stress, it is the responsibility of the customer, when utilizing Paceleader products, to comply with the standards of safety in making a safe design for entire system and to avoid situation in which a malfunction or failure., In developing a new designs, customer should ensure that the device which shown in this documents are used within specified operating ranges.

- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by Paceleader for any infringements of patents or other rights of the third parties which may result from its use.